Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination	
10638397	CHANG, LIN-WEI	
Examiner	Art Unit	
Kosowski, Alexander J	2125	

SEARCHED					
Class	Subclass	Date	Examiner		
700	90	12/20/07	AJK		
361	685,727				
Above	updated	4/16/08	AJK		

SEARCH NOTES				
Search Notes	Date	Examiner		
EAST Search (attached)	12/20/07	AJK		
EIC TC2100 PLUS Search				
Consulted Primary Examiner in AU2835 for search assistance				
PALM Inventor Name Search				
EAST Search (updated)	4/16/08	AJK		
Interference Search				

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		
700	90	4/16/08	AJK		
361	685,727				

U.S. Patent and Trademark Office Part of Paper No.: 20080416